


<b>Search Notes</b>  	<b>Application/Control No.</b>  10577896	<b>Applicant(s)/Patent Under Reexamination</b>  HACK ET AL.
	<b>Examiner</b>  ALEXANDER C WITKOWSKI	<b>Art Unit</b>  2853

SEARCHED			
Class	Subclass	Date	Examiner
347	20, 47, 77, 78, 82.	01/24/2009	ACW

SEARCH NOTES		
Search Notes	Date	Examiner
Stephen D. Meier, Supervisory Patent Examiner.	09/21/2008	ACW
Limited classification search: 347/ 47	09/21/2008	ACW
Text search; see search history.	09/21/2008	ACW
Limited classification search: 347/ 20, 47, 77, 78, 82.	01/24/2009	ACW
Class-wide search: 347.	01/24/2009	ACW
Text search. See search history.	01/24/2009	ACW

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
347	Class-wide: 347/\$.ccls.	01/24/2009	ACW

/A. C. W./  
Examiner.Art Unit 2853